

UC1845A-SP QML V 类 耐辐射电流模式 PWM 控制器

1 特性

- 符合 QML V 类 (QMLV) 标准, SMD 5962-86704
- 5962P8670411Vxx: ⁽¹⁾
 - 抗辐射加固保障 (RHA) 能力高达 30-krad(Si) 总电离剂量 (TID)
 - 通过了 45krad/LDR (10mrad/s) 测试条件 (符合 MIL-STD-883 测试方法 1019.9 的 3.13.3.b 小节定义的 1.5 倍过量测试) 下的功能性测试且在规定的后辐射参数限值范围内
 - 展现出低剂量率灵敏度 ⁽²⁾但在 30krad 总剂量水平下仍保持在 MIL-STD-883, TM1019 所允许的预辐射电气限制范围内
- 经过优化适用于 DC-DC 转换器 应用
- 低启动电流 (< 0.5mA)
- 修整的振荡器放电电流
- 自动前馈补偿
- 逐脉冲电流限制
- 增强型负载响应特性
- 带滞后的欠压闭锁 (UVLO) 保护
- 双脉冲抑制
- 高电流推挽式输出
- 内部调整的带隙参考
- 500kHz 工作频率
- 低 R_O 误差放大器
- 支持军用级温度范围 (-55°C 至 125°C)

- (1) 改进的 TID 辐射性能仅适用于抗辐射加固保障 (RHA) 器件类型 11。
- (2) 受影响的参数参考输出电压, V_{REF} 辐射漂移曲线 (请参见 [VREF 辐射漂移曲线](#))。

2 应用

- 抗辐射加固型 DC-DC 转换器
- 卫星本体和有效载荷
- 太空运载火箭
- 水下布线
- 支持多种拓扑结构:
 - 反激、正激、降压、升压
 - 推挽、半桥、全桥 (采用外部接口电路时)

3 说明

UC1845A-SP 控制 IC 是与 UC184x 系列引脚兼容的抗辐射加固版。它主要适用于卫星和其他恶劣环境应用。该器件提供了控制电流模式开关电源所必需的特性, 并改进了多种功能。额定启动电流低于 0.5mA, 振荡器放电电流调整为 8.3mA。UVLO 期间, 输出级在低于 1.2V 的电压下至少具有 10mA 的灌电流能力 (V_{CC} 高于 5V)。

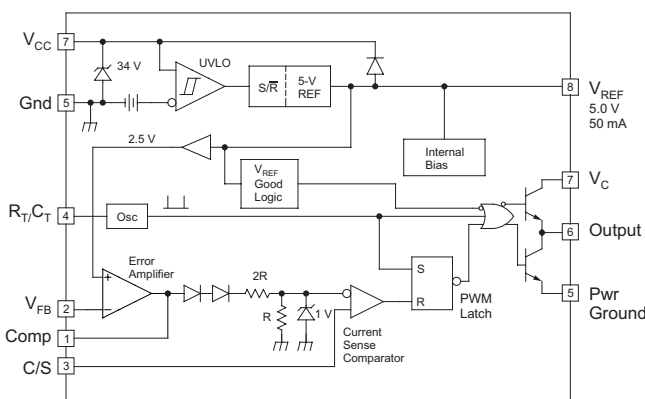
器件比较表显示了该系列各成员器件间的不同之处。要订购辐射改进型版本 (如已提供), 请参考相应的产品数据表。

器件信息⁽¹⁾

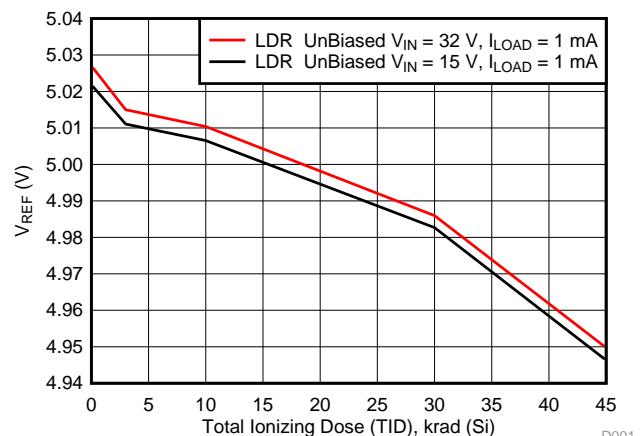
器件型号	封装	封装尺寸 (标称值)
UC1845A-SP	CDIP/JG (8)	6.67mm x 9.60mm
	LCCC/FK (20)	8.89mm x 8.89mm
	CFP/HKU (10)	6.48mm x 7.02mm

- (1) 如需了解所有可用封装, 请参阅数据表末尾的可订购产品附录。

简化电路原理图



V_{REF} 辐射漂移曲线



D001



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4 修订历史记录

Changes from Original (May 2015) to Revision A

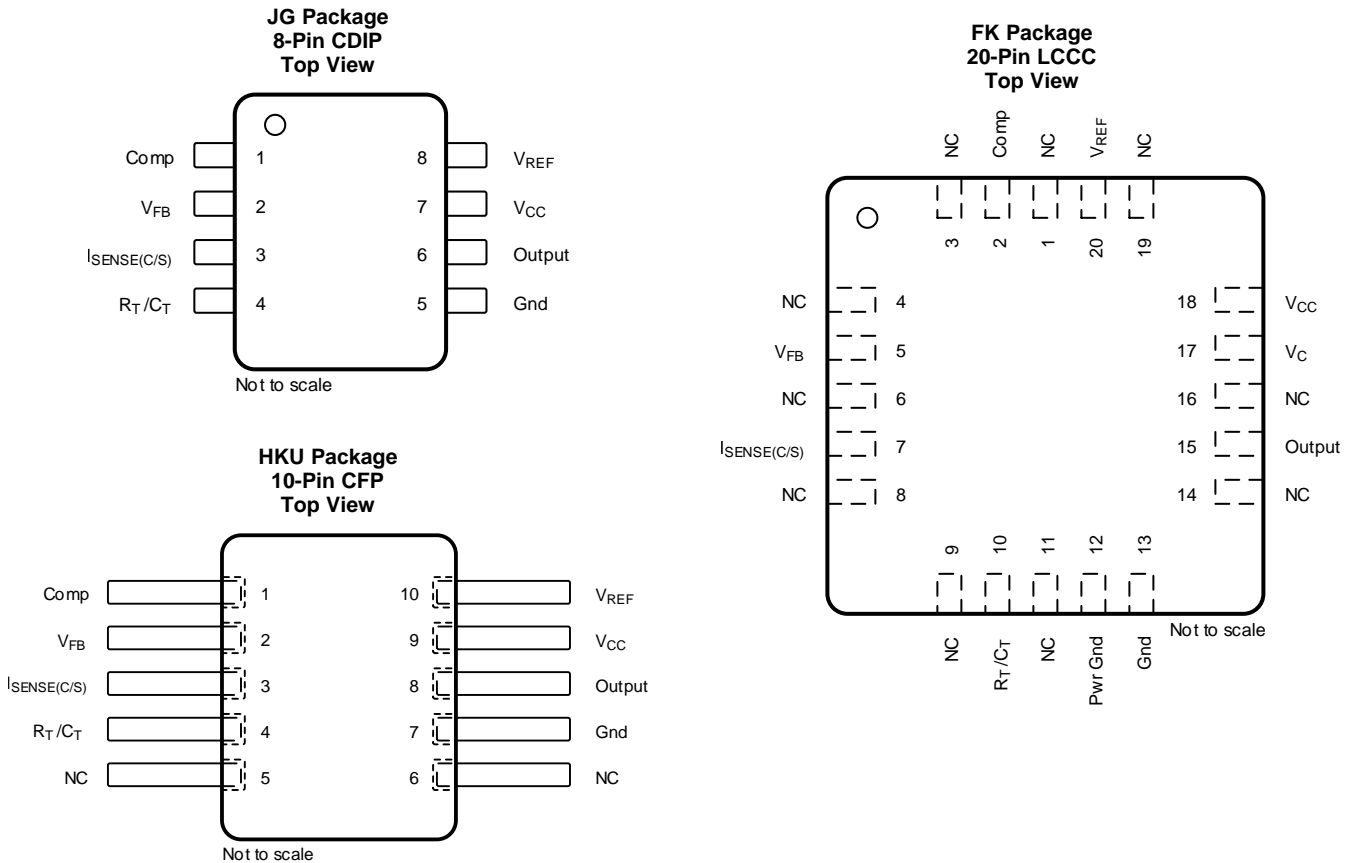
Page

•	Changed the <i>Pin Configuration</i> images	3
•	Changed CT (pF) To: CT (μF) in Equation 1	15

5 Device Comparison Table

PART NO.	UVLO ON	UVLO OFF	MAXIMUM DUTY CYCLE
UC1842A	16 V	10 V	<100%
UC1843A	8.5 V	7.9 V	<100%
UC1844A	16 V	10 V	<50%
UC1845A	8.5 V	7.9 V	<50%

6 Pin Configuration and Functions



Pin Functions

NAME	PIN			I/O	DESCRIPTION
	CDIP	LCCC	CFP		
Comp	1	2	1	I	Error amplifier output.
V _{FB}	2	5	2	I	Voltage feedback input to error amplifier.
I _{SENSE(C/S)}	3	7	3	I	Current sense comparator input pin.
R _T /C _T	4	10	4	I	RC time constant input to oscillator.
NC	—	1, 3, 4, 6, 8, 9, 11, 14, 16, 19	5, 6	—	No connect.
Pwr Gnd	—	12	—	—	Output section ground.
Gnd	5	13	7	—	Ground.
Output	6	15	8	O	Regulated output.
V _C	—	17	—	—	Output section supply voltage.
V _{CC}	7	18	9	—	Unregulated supply voltage.

Pin Functions (continued)

PIN				I/O	DESCRIPTION
NAME	CDIP	LCCC	CFP		
V _{REF}	8	20	10	O	5-V internally generated reference.

7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾

over operating free-air temperature (unless otherwise noted)

		MIN	MAX	UNIT
V _{CC}	Supply voltage, low-impedance source		30	V
V _I	Input voltage (V _{FB} , I _{SENSE})	-0.3	6.3	V
	Supply current	Self limiting		
I _O	Output current		±1	A
	Error amplifier output sink current		10	mA
	Output energy (capacitive load)		5	μJ
P _D	Power dissipation (T _A = 25°C)		1	W
T _J	Junction temperature		150	°C
T _{stg}	Storage temperature	-65	150	°C

- Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- All voltages are with respect to ground. Currents are positive in, negative out of the specified terminal.

7.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±4000	V

- JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

 over operating free-air temperature range (T_A = T_J = -55°C to 125°C), unless otherwise noted

		MIN	MAX	UNIT
V _{CC}	Supply voltage	12	25	V
	Sink/source output current (continuous or time average)	0	200	mA
	Reference load current	0	20	mA

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		UC1845A-SP			UNIT
		JG (CDIP)	FK (LCCC)	HKU (CFP)	
		8 PINS	20 PINS	10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	103	—	51.9	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	9.6	9.0	6.6	°C/W
R _{θJB}	Junction-to-board thermal resistance	69.2	—	31.5	°C/W
ψ _{JT}	Junction-to-top characterization parameter	13.9	—	5.42	°C/W
ψ _{JB}	Junction-to-board characterization parameter	73	—	31	°C/W

- For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

7.5 Electrical Characteristics

 $V_{CC} = 15\text{ V}^{(1)}$, $R_T = 10\text{ k}\Omega$, $C_T = 3.3\text{ nF}$, $T_A = T_J = -55^\circ\text{C}$ to 125°C (unless otherwise noted) ⁽²⁾

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
REFERENCE						
Output voltage	$T_J = 25^\circ\text{C}$, $I_O = 1\text{ mA}$, $V_{CC} = 15\text{ V}$	5962-8670408VxA	4.95	5	5.06	V
		5962P8670411Vxx Pre-radiation	4.94	5	5.06	
		5962P8670411Vxx Post-radiation	4.85		5.06	
Line regulation	$V_{IN} = 12\text{ to }25\text{ V}$		6	20	mV	
Load regulation	$I_O = 1\text{ to }20\text{ mA}$		6	25	mV	
Temperature stability ⁽³⁾⁽⁴⁾⁽⁵⁾			0.2	0.4	mV/ $^\circ\text{C}$	
Total output variation ⁽³⁾	Over line, load, and temperature	4.9		5.1	V	
Output noise variation	$10\text{ Hz} \leq f \leq 10\text{ kHz}$, $T_J = 25^\circ\text{C}$		50		μV	
Long-term stability ⁽⁵⁾	1000 hours, $T_A = 125^\circ\text{C}^{(3)}$		5	25	mV	
Short-circuit output current		-30	-100	-180	mA	
OSCILLATOR						
Initial accuracy	$T_J = 25^\circ\text{C}^{(6)}$	47	52	57	kHz	
Voltage stability	$V_{CC} = 12\text{ to }25\text{ V}$		0.2%	1%		
Temperature stability	$T_J = -55^\circ\text{C}$ to $125^\circ\text{C}^{(3)}$		5%			
Amplitude	$V_{RT/CT}$ peak to peak ⁽³⁾		1.7		V	
Discharge current	V pin 4 = $2\text{ V}^{(7)}$	$T_J = 25^\circ\text{C}$	7.8	8.3	8.8	mA
		$T_J = \text{Full range}$	7.5		8.8	mA
ERROR AMPLIFIER						
Input voltage	$V_{Comp} = 2.5\text{ V}$	2.45	2.50	2.55	V	
Input bias current			-0.3	-1	μA	
Open-loop voltage gain	$V_O = 2\text{ to }4\text{ V}$	65	90		dB	
Unity-gain bandwidth	$T_J = 25^\circ\text{C}^{(3)}$	0.7	1		MHz	
PSRR	$V_{CC} = 12\text{ to }25\text{ V}$	60	70		dB	
Output sink current	$V_{FB} = 2.7\text{ V}$, $V_{Comp} = 1.1\text{ V}$	2	6		mA	
Output source current	$V_{FB} = 2.3\text{ V}$, $V_{Comp} = 5\text{ V}$	-0.5	-0.8		mA	
High-level output voltage	$V_{FB} = 2.3\text{ V}$, $R_L = 15\text{ k}\Omega$ to ground	5	6		V	
Low-level output voltage	$V_{FB} = 2.7\text{ V}$, $R_L = 15\text{ k}\Omega$ to V_{REF}		0.7	1.1	V	
CURRENT SENSE						
Gain ⁽⁸⁾⁽⁹⁾		2.85	3	3.15	V/V	
Maximum input signal	$V_{Comp} = 5\text{ V}^{(8)}$	0.9	1	1.1	V	
PSRR	$V_{CC} = 12\text{ to }25\text{ V}^{(8)}$		70		dB	
Input bias current			-2	-10	μA	
Delay to output	$V_{ISENSE} = 0\text{ to }2\text{ V}^{(3)}$		150	300	ns	

(1) Adjust V_{CC} above the start threshold before setting at 15 V.

(2) See [机械、封装和可订购信息](#) for radiation improved devices.

(3) Parameters ensured by design and/or characterization, if not production tested.

(4) Temperature stability, sometimes referred to as average temperature coefficient, is described by the equation:
Temperature Stability = $(V_{REF}(\text{max}) - V_{REF}(\text{min})) / (T_J(\text{max}) - T_J(\text{min}))$. $V_{REF}(\text{max})$ and $V_{REF}(\text{min})$ are the maximum and minimum reference voltage measured over the appropriate temperature range. Note that the extremes in voltage do not necessarily occur at the extremes in temperature.

(5) Parameter applies only for 5962-8670408VxA.

(6) Output frequency is one-half oscillator frequency for UC1845A.

(7) This parameter is measured with $R_T = 10\text{ k}\Omega$ to V_{REF} . This contributes approximately 300 μA of current to the measurement. The total current flowing into the R_T or C_T pin will be approximately 300 μA higher than the measured value.

(8) Parameter measured at trip point of latch with $V_{FB} = 0\text{ V}$.

(9) Gain defined as: $G = \Delta V_{Comp} / \Delta V_{ISENSE}$; $V_{ISENSE} = 0$ to 0.8 V.

Electrical Characteristics (continued)

$V_{CC} = 15\text{ V}^{(1)}$, $R_T = 10\text{ k}\Omega$, $C_T = 3.3\text{ nF}$, $T_A = T_J = -55^\circ\text{C}$ to 125°C (unless otherwise noted) ⁽²⁾

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT					
Output low-level voltage	$I_{SINK} = 20\text{ mA}$		0.1	0.4	V
	$I_{SINK} = 200\text{ mA}$		1.5	2.2	
Output high-level voltage	$I_{SOURCE} = -20\text{ mA}$	13	13.5		V
	$I_{SOURCE} = -200\text{ mA}$	12	13.5		
Rise time	$C_L = 1\text{ nF}$, $T_J = 25^\circ\text{C}^{(3)}$		50	150	ns
Fall time	$C_L = 1\text{ nF}$, $T_J = 25^\circ\text{C}^{(3)}$		50	150	ns
UVLO saturation	$V_{CC} = 5\text{ V}$, $I_{SINK} = 10\text{ mA}$		0.7	1.2	V
UNDERVOLTAGE LOCKOUT					
Start threshold		7.8	8.4	9	V
Minimum operation voltage after turnon		7	7.6	8.2	V
PWM					
Maximum duty cycle		47%	48%	50%	
Minimum duty cycle				0%	
TOTAL STANDBY CURRENT					
Start-up current			0.3	0.5	mA
Operating supply current	$V_{FB} = V_{ISENSE} = 0\text{ V}$		11	17	mA
V_{CC} Zener voltage	$I_{CC} = 25\text{ mA}$	30	34		V

7.6 Typical Characteristics

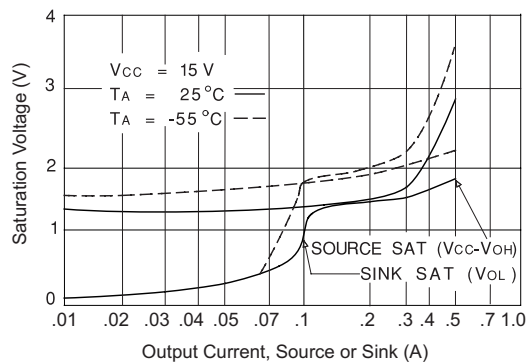


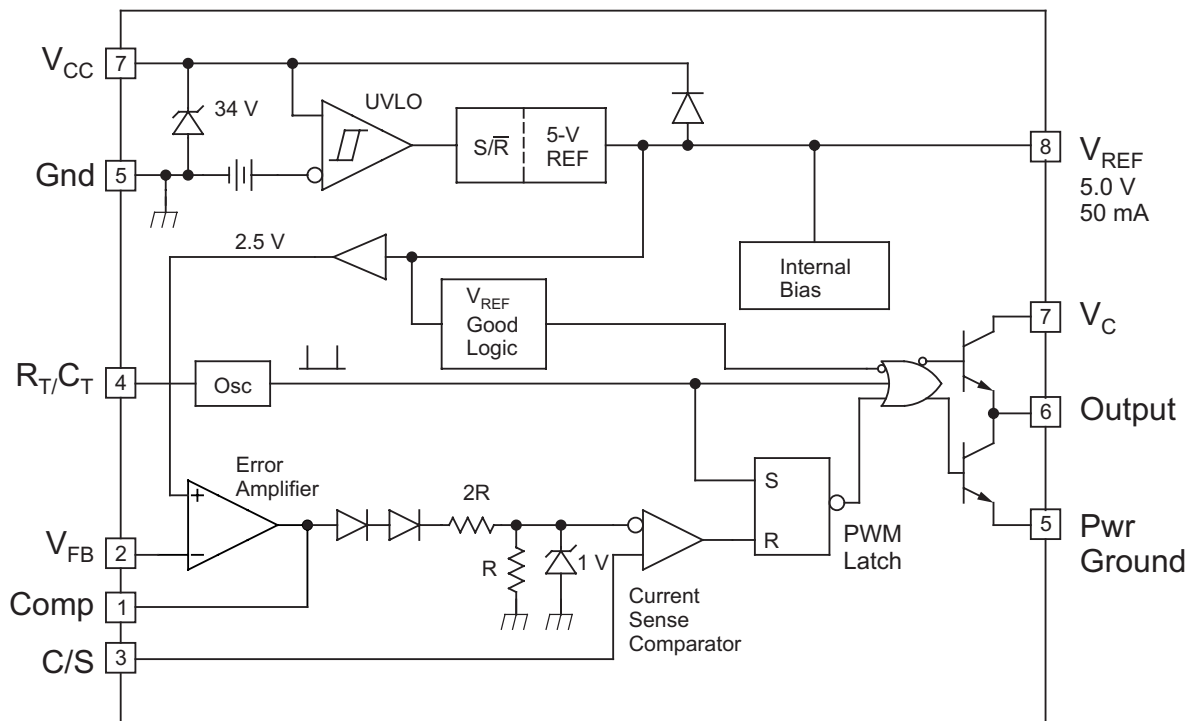
Figure 1. Output Saturation Characteristics

8 Detailed Description

8.1 Overview

The UC1845A-SP control IC is a pin-for-pin compatible improved version of the UC184x family. Providing the necessary characteristics to control current-mode switched-mode power supplies, this device has improved features. Start-up current is specified to be less than 0.5 mA and oscillator discharge is trimmed to 8.3 mA. During UVLO, the output stage can sink at least 10 mA at less than 1.2 V for V_{CC} over 5 V.

8.2 Functional Block Diagram



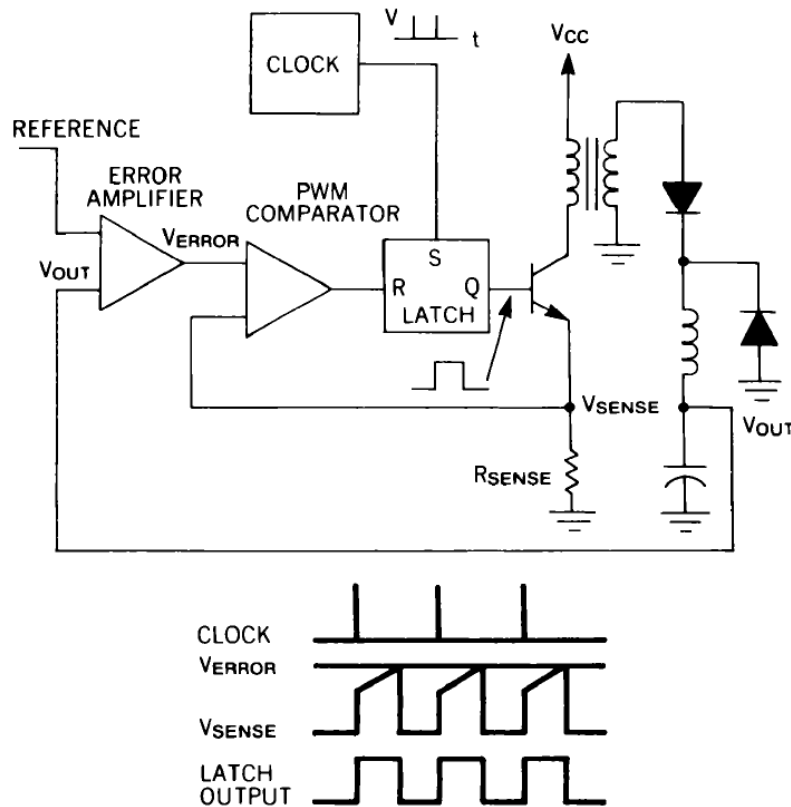
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8.3 Feature Description

UC1845A-SP is a current mode controller, used to support various topologies such as forward, flyback, buck, boost and using an external interface circuit will also support half-bridge, full-bridge, and push-pull configurations.

Figure 2 shows the two-loop current-mode control system in a typical buck regulator application. A clock signal initiates power pulses at a fixed frequency. The termination of each pulse occurs when an analog of the inductor current reaches a threshold established by the error signal. In this way, the error signal actually controls peak inductor current. This contrasts with conventional schemes in which the error signal directly controls pulse width without regard to inductor current.

Several performance advantages result from the use of current-mode control. First, an input voltage feed-forward characteristic is achieved; that is, the control circuit instantaneously corrects for input voltage variations without using up any of the error amplifier's dynamic range. Therefore, line regulation is excellent and the error amplifier can be dedicated to correcting for load variations exclusively.

Feature Description (continued)


0019-1

Figure 2. Two-Loop Current-Mode Control System

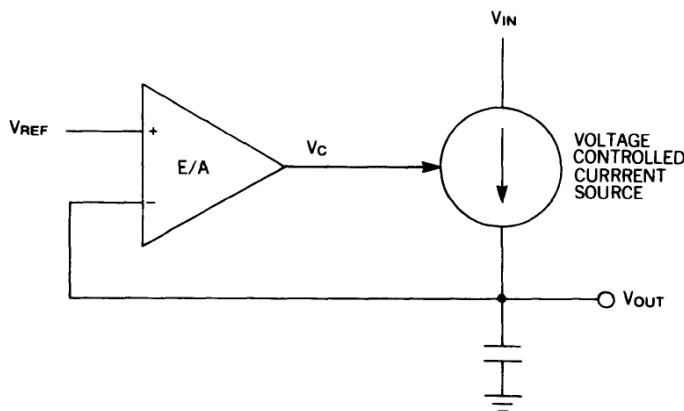
For converters in which inductor current is continuous, controlling peak current is nearly equivalent to controlling average current. Therefore, when such converters employ current-mode control, the inductor can be treated as an error-voltage-controlled-current-source for the purposes of small-signal analysis (see [Figure 3](#)). The two-pole control-to-output frequency response of these converters is reduced to a single-pole (filter capacitor in parallel with load) response. One result is that the error amplifier compensation can be designed to yield a stable closed-loop converter response with greater gain bandwidth than would be possible with pulse-width control, giving the supply improved small-signal dynamic response to changing loads. A second result is that the error amplifier compensation circuit becomes simpler, as shown in [Figure 4](#).

Capacitor C_i and resistor R_i , in [Figure 4\(A\)](#), add a low-frequency zero, which cancels one of the two control-to-output poles of non-current-mode converters. For large signal load changes, in which converter response is limited by inductor slew rate, the error amplifier saturates while the inductor is catching up with the load. During this time, C_i charges to an abnormal level. When the inductor current reaches its required level, the voltage on C_i causes a corresponding error in supply output voltage. The recovery time is $R_{iz}C_i$, which may be long. However, the compensation network of [Figure 4\(B\)](#) can be used where current-mode control has eliminated the inductor pole. Large-signal dynamic response is then greatly improved due to the absence of C_i .

Current limiting is greatly simplified with current-mode control. Pulse-by-pulse limiting is, of course, inherent in the control scheme. Furthermore, an upper limit on the peak current can be established by simply clamping the error voltage. Accurate current limiting allows optimization of magnetic and power semiconductor elements while ensuring reliable supply operation.

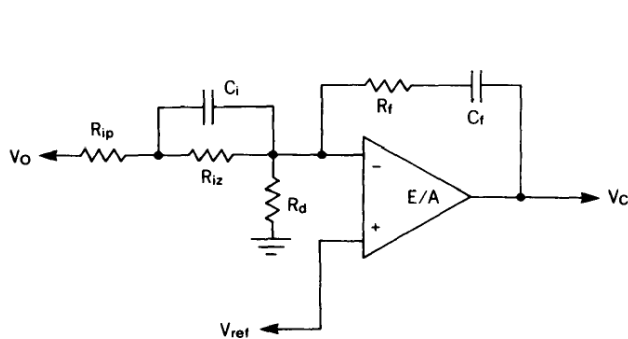
Finally, current-mode controlled power stages can be operated in parallel with equal current sharing. This opens the possibility of a modular approach to power supply design.

Feature Description (continued)

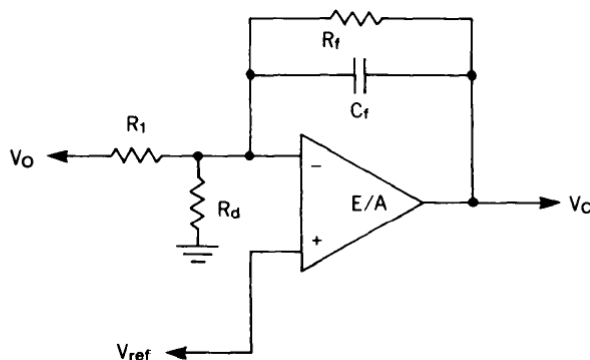


0019-2

Figure 3. Inductor Looks Like a Current Source to Small Signals



0019-3



0019-4

A. Direct duty cycle control

B. Current mode control

Figure 4. Required Error Amplifier Compensation for Continuous Inductor Current Designs

8.3.1 UVLO

The UVLO circuit ensures that V_{CC} is adequate to make the UC1845A-SP fully operational before enabling the output stage. Figure 5 shows that the UVLO turnon and turnoff thresholds are fixed internally at 8.5 V and 7.9 V, respectively. The 0.6-V hysteresis prevents V_{CC} oscillations during power sequencing.

Figure 6 shows supply current requirements. Start-up current is < 1 mA for efficient bootstrapping from the rectified input of an off-line converter, as shown in Figure 7. During normal circuit operation, V_{CC} is developed from auxiliary winding, $WAux$, with D_1 and C_{IN} . However, at start-up, C_{IN} must be charged to 16 V through R_{IN} . With a start-up current of 1 mA, R_{IN} can be as large as 100 k Ω and still charge C_{IN} when $V_{Ac} = 90$ -V RMS (low line). Power dissipation in R_{IN} would then be less than 350 mW even under high line ($V_{Ac} = 130$ -V RMS) conditions.

During UVLO, the output driver is in a low state. While it does not exhibit the same saturation characteristics as normal operation, it can easily sink 1 mA, enough to ensure the MOSFET is held off.

Feature Description (continued)

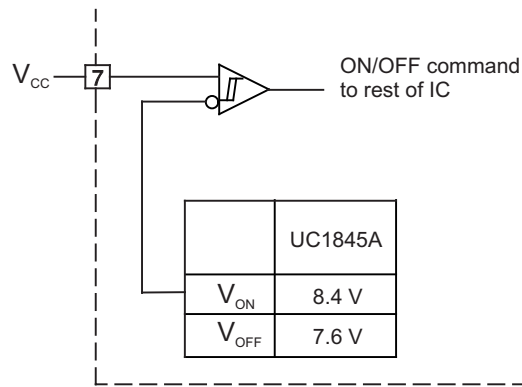
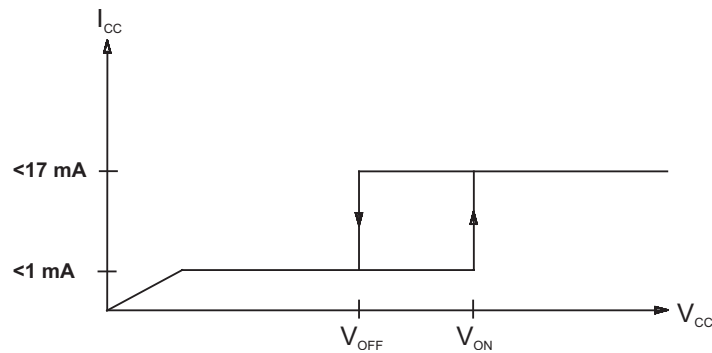
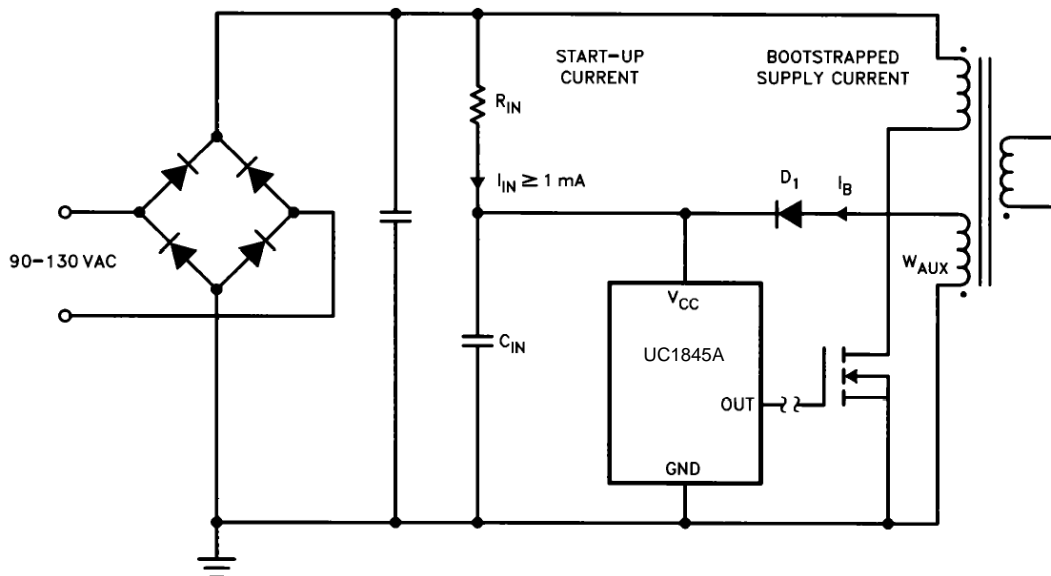


Figure 5. UVLO Turnon TurnOff Threshold



During UVLO, the output driver is biased to sink minor amounts of current.

Figure 6. Supply Current Requirements



0019-8

Figure 7. Providing Power to the UC1845A-SP

Feature Description (continued)

8.3.2 Reference

As highlighted in the [Functional Block Diagram](#), UC1845A-SP incorporates a 5-V internal reference regulator with $\pm 2\%$ set point variation over temperature.

8.3.3 Totem-Pole Output

The UC1845A-SP PWM has a single totem-pole output which can be operated to ± 1 -A peak for driving MOSFET gates, and a +200 mA average current for bipolar power U-100A transistors. Cross conduction between the output transistors is minimal, the average added power with $V_{IN} = 30$ V is only 80 mW at 200 kHz.

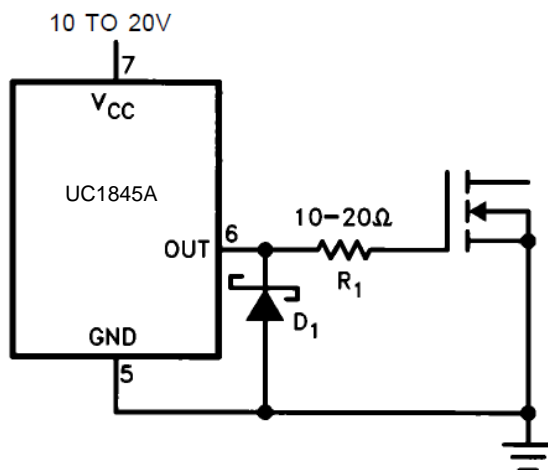
Limiting the peak current through the IC is accomplished by placing a resistor between the totem-pole output and the gate of the MOSFET. The value is determined by dividing the totem-pole collector voltage V_C by the peak current rating of the IC's totem-pole. Without this resistor, the peak current is limited only by the dV/dT rate of the totem-pole switching and the FET gate capacitance.

The use of a Schottky diode from the PWM output to ground prevents the output voltage from going excessively below ground, causing instabilities within the IC. To be effective, the diode selected should have a forward drop of less than 0.3 V at 200 mA. Most 1- to 3-A Schottky diodes exhibit these traits above room temperature. Placing the diode as physically close to the PWM as possible enhances circuit performance. Implementation of the complete drive scheme is shown in [Figure 8](#) through [Figure 10](#). Transformer-driven circuits also require the use of the Schottky diodes to prevent a similar set of circumstances from occurring on the PWM output. The ringing below ground is greatly enhanced by the transformer leakage inductance and parasitic capacitance, in addition to the magnetizing inductance and FET gate capacitance. Circuit implementation is similar to the previous example.

[Figure 8](#) through [Figure 10](#) show suggested circuits for driving MOSFETs and bipolar transistors with the UC1845A-SP output. The simple circuit of [Figure 8](#) can be used when the control IC is not electrically isolated from the MOSFET turnon and turnoff to ± 1 A. It also provides damping for a parasitic tank circuit formed by the FET input capacitance and series wiring inductance. Schottky diode, D_1 , prevents the output of the IC from going far below ground during turnoff.

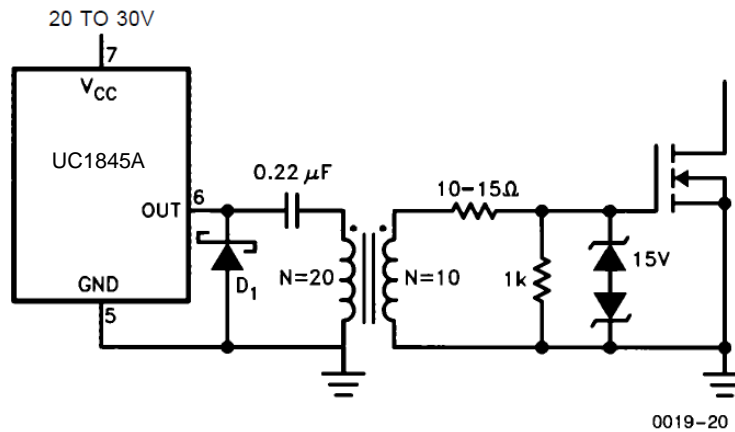
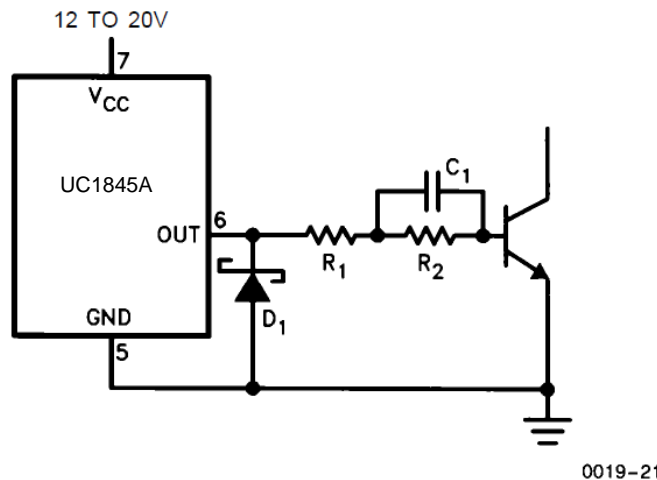
[Figure 9](#) shows an isolated MOSFET drive circuit which is appropriate when the drive signal must be level shifted or transmitted across an isolation boundary. Bipolar transistors can be driven efficiently with the circuit of [Figure 10](#). Resistors R_1 and R_2 fix the on-state base current while capacitor C_1 provides a negative base current pulse to remove stored charge at turnoff.

Because the UC1845A-SP series has only a single output, an interface circuit is needed to control push-pull, half-bridge, or full-bridge topologies. The UC1706 dual output driver with internal toggle flip-flop performs this function. [Typical Application](#) shows a typical application for these two ICs. Increased drive capability for driving numerous FETs in parallel, or other loads can be accomplished using one of the UC1705/6/7 driver ICs.



0019-19

Figure 8. Direct MOSFET Drive

Feature Description (continued)

Figure 9. Isolated MOSFET Drive

Figure 10. Bipolar Drive With Negative turnoff Bias
8.4 Device Functional Modes

The UC1845A-SP uses fixed frequency, peak current mode control. An internal oscillator initiates the turn on of the driver to high-side power switch. The external power switch current is sensed through an external resistor and is compared via internal comparator. The voltage generated at the COMP pin is stepped down via internal resistors (as shown in the functional block diagram). When the sensed current reaches the stepped down COMP voltage, the high-side power switch is turned off.

9.2.2 Detailed Design Procedure

See [Table 2](#) for component values.

Table 2. Components⁽¹⁾

COMPONENT	VALUE
R1	5 Ω , 1 W
R2	56 k Ω , 2 W
R3	20 k Ω
R4	4.7 k Ω
R5	150 k Ω
R6	10 k Ω
R7	22 Ω
R8	1 k Ω
R9	68 Ω
R10	0.55 Ω , 1 W
R11	2.7 k Ω , 2 W
R12	4.7 k Ω , 2 W
R13	20 k Ω
C1	250 μ F, 250 V
C2	100 μ F, 25 V
C3	22 μ F
C4	47 μ F, 25 V
C5	0.1 μ F
C6	0.0022 μ F
C7	470 pF
C8	680 pF, 600 V
C9	3300 pF, 600 V
C10	4700 μ F, 10 V
C11	4700 μ F, 10 V
C12	2200 μ F, 10 V
C13	2200 μ F, 10 V
C14	100 pF
D2	1N3612
D3	1N3612
D4	1N3613
D5	1N3613
D6	USD945
D7	UFS1002
D8	UES1002
Q1	UFN833

(1) See [Figure 11](#) for reference.

9.2.2.1 Oscillator

The UC1845A-SP oscillator is programmed as shown in [Figure 13](#). Timing capacitor C_T is charged from V_{REF} (5 V) through the timing resistor R_T , and discharged by an internal current source. The first step in selecting the oscillator components is to determine the required circuit dead time. Once obtained, [Figure 14](#) is used to pinpoint the nearest standard value of C_T for a given dead time. Next, the appropriate R_T value is interpolated using the parameters for C_T and oscillator frequency. [Figure 15](#) shows the R_T/C_T combinations versus oscillator frequency. The timing resistor can be calculated from the following formula.

$$f_{osc} \text{ (kHz)} = \frac{1.72}{R_T \text{ (k}\Omega) \times C_T \text{ (}\mu\text{F)}} \quad (1)$$

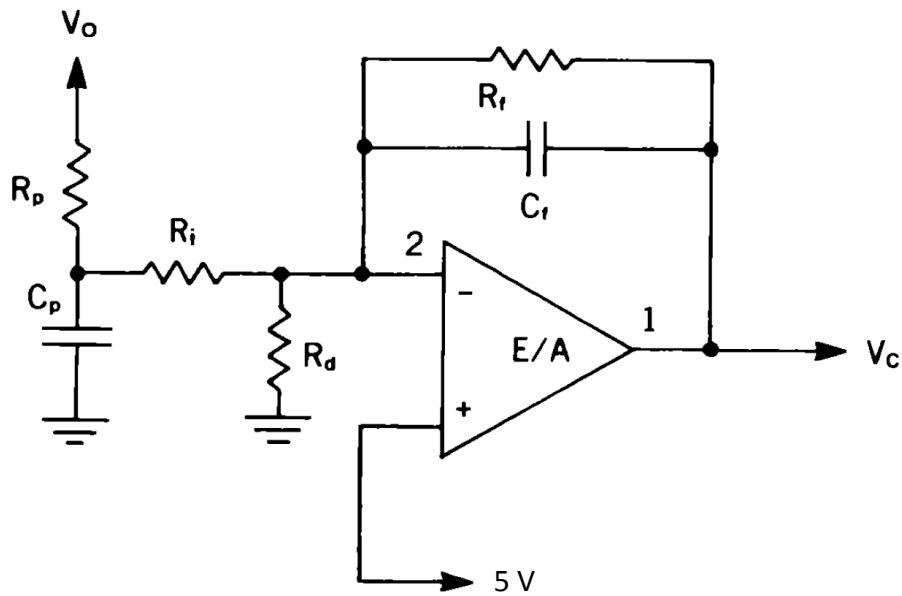


Figure 12. E/A Compensation Circuit for Continuous Boost and Flyback Topologies

The UC1845A-SP has an internal divide-by-two flip-flop driven by the oscillator for a 50% maximum duty cycle. Therefore, their oscillators must be set to run at twice the desired power supply switching frequency.

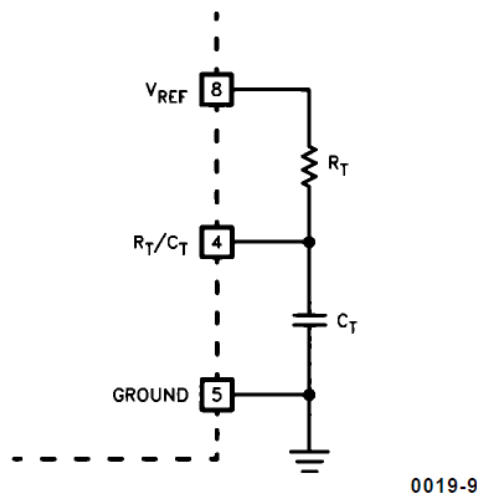
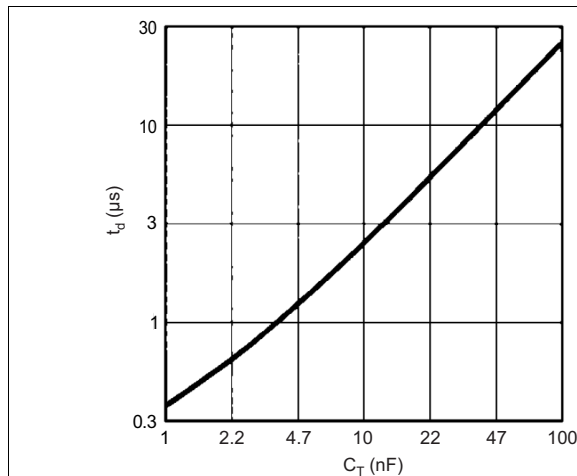
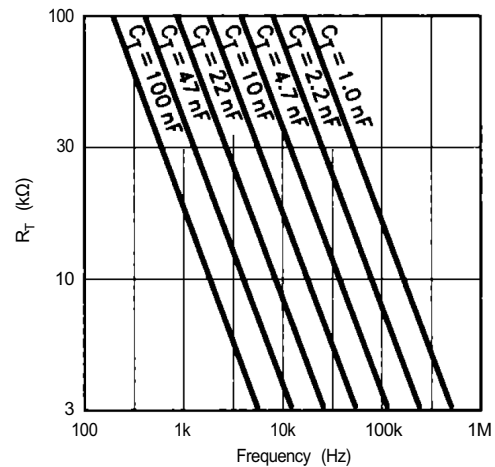


Figure 13. Oscillator Programming


Figure 14. Dead Time vs C_T (R_T > 5 kΩ)

Figure 15. Timing Resistance vs Frequency

9.2.2.2 Current Sensing and Limiting

The UC1845A-SP current sense input is configured as shown in [Figure 16](#). Current-to-voltage conversion is done externally with ground-referenced resistor R_S. Under normal operation, the peak voltage across R_S is controlled by the E/A according to the following relation:

$$I_p = \frac{V_C - 1.4 \text{ V}}{3 R_S}$$

where

- V_C = Control voltage = E/A output voltage (2)

R_S can be connected to the power circuit directly or through a current transformer, as [Figure 16](#) shows. While a direct connection is simpler, a transformer can reduce power dissipation in R_S, reduce errors caused by the base current, and provide level shifting to eliminate the restraint of ground-referenced sensing. The relation between V_C and peak current in the power stage is given by:

$$i_{(pk)} = N \left(\frac{V_{R_S(pk)}}{R_S} \right) = \frac{N}{3 R_S} (V_C - 1.4 \text{ V})$$

where

- N = Current sense transformer turns ratio = 1 when transformer not used. (3)

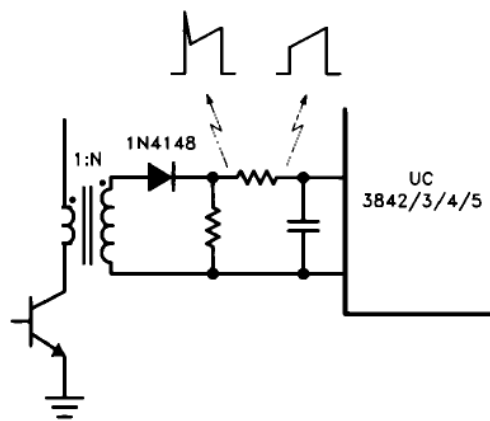
For purposes of small-signal analysis, the control-to-sensed-current gain is:

$$\frac{i_{(pk)}}{V_C} = \frac{N}{3 R_S} \tag{4}$$

When sensing current in series with the power transistor, as shown in [Figure 16](#), the current waveform often has a large spike at its leading edge. This spike is due to rectifier recovery and/or inter-winding capacitance in the power transformer. If unattenuated, this transient can prematurely terminate the output pulse. As shown, a simple RC filter is usually adequate to suppress this spike. The RC time constant should be approximately equal to the current spike duration (usually a few hundred nanoseconds).

The inverting input to the UC1845A-SP current-sense comparator is internally clamped to 1 V ([Figure 16](#)). Current limiting occurs if the voltage at pin 3 reaches this threshold value, that is, the current limit is defined by:

$$i_{max} = \frac{N \times 1 \text{ V}}{R_S} \tag{5}$$



0019-13

Figure 16. Transformer-Coupled Current Sensing

9.2.2.3 Error Amplifier

The error amplifier (E/A) configuration is shown in Figure 17. The non-inverting input is not brought out to a pin, but is internally biased to 5 V \pm 2%. The E/A output is available at pin 1 for external compensation, allowing the user to control the converter's closed-loop frequency response.

Figure 18 shows an E/A compensation circuit suitable for stabilizing any current-mode controlled topology except for flyback and boost converters operating with inductor current. The feedback components add a pole to the loop transfer function at $f_p = \frac{1}{2} \pi R_F$. R_F and C_F are chosen so that this pole cancels the zero of the output filter capacitor ESR in the power circuit. R_I and R_F fix the low-frequency gain. They are chosen to provide as much gain as possible while still allowing the pole formed by the output filter capacitor and load to roll off the loop gain to unity (0 dB) at $f \approx f_{\text{SWITCHING}} / 4$. This technique ensures converter stability while providing good dynamic response.

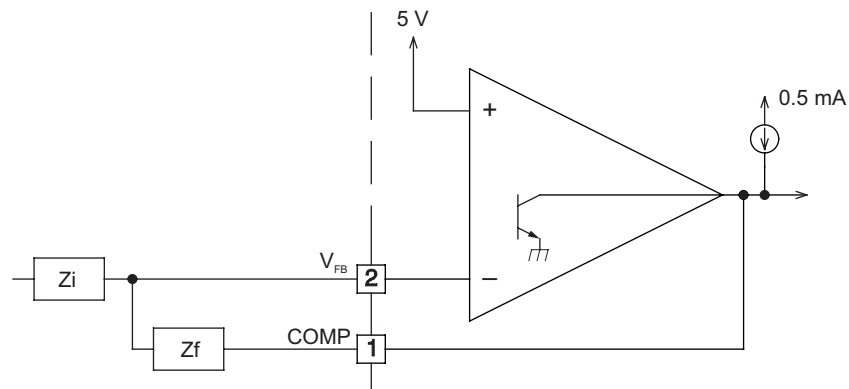
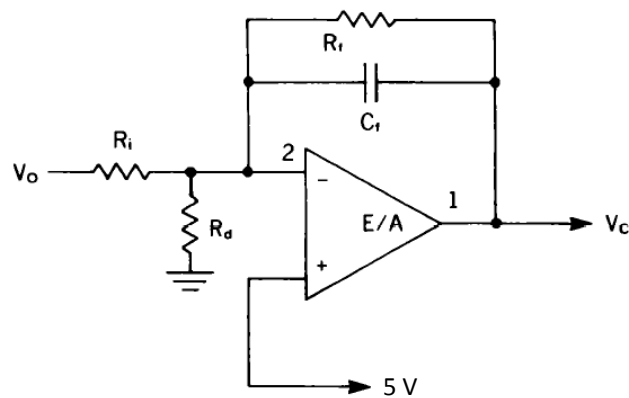


Figure 17. E/A Configuration



0019-15

Figure 18. Compensation

The E/A output sources 0.5 mA and sinks 2 mA. A lower limit for R_F is given by:

$$R_{F(MIN)} \approx \frac{V_{EA\ OUT(MAX)} - 2.5\ V}{0.5\ mA} = \frac{6\ V - 2.5\ V}{0.5\ mA} = 7\ k\Omega \quad (6)$$

E/A input bias current (2- μ A max) flows through R_i , resulting in a DC error in output voltage (V_O) given by:

$$\Delta V_{O(MAX)} = (2\ \mu A) R_i \quad (7)$$

Therefore, the designer should keep the value of R_i , as low as possible.

Figure 19 shows the open-loop frequency response of the UC1845A-SP E/A. The gain represents an upper limit on the gain of the compensated E/A. Phase lag increases rapidly as frequency exceeds 1 MHz due to second-order poles at about 10 MHz and above.

Continuous-inductor-current boost and flyback converters each have a right-half-plane zero in their transfer function. An additional compensation pole is needed to roll off loop gain at a frequency less than that of the RHP zero. R_P and C_P in the circuit of Figure 12 provide this pole.

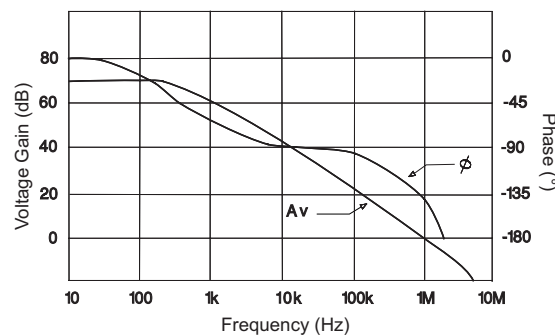


Figure 19. Error Amplifier Open-Loop Frequency Response

9.2.3 Application Curves

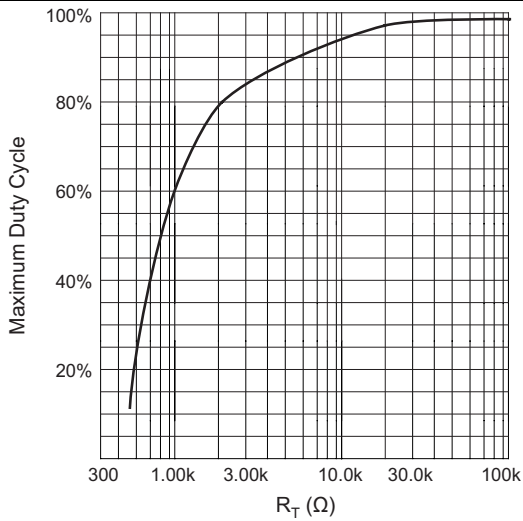


Figure 20. Oscillator Frequency vs Timing Resistance

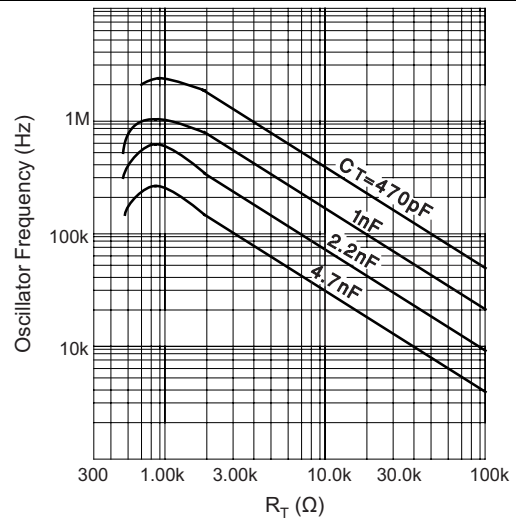
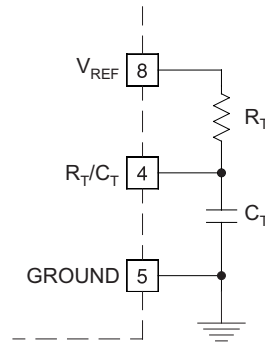


Figure 21. Maximum Duty Cycle vs Timing Resistor



For $R_T > 5k$ $f \approx 1.72 / (R_T C_T)$

Figure 22. Oscillation Schematic

Layout Guidelines (continued)

11.1.2 Input/Output Capacitors

When using a low-value ceramic input filter capacitor, locate it as close as possible to the VIN pin of the IC. This eliminates as much trace inductance effects as possible and gives the internal IC rail a cleaner voltage supply. Some designs require the use of a feed-forward capacitor connected from the output to the feedback pin as well, usually for stability reasons. In this case, it should also be positioned as close as possible to the IC. Using surface mount capacitors also reduces lead length and lessens the chance of noise coupling into the effective antenna created by through-hole components.

11.1.3 Compensation Components

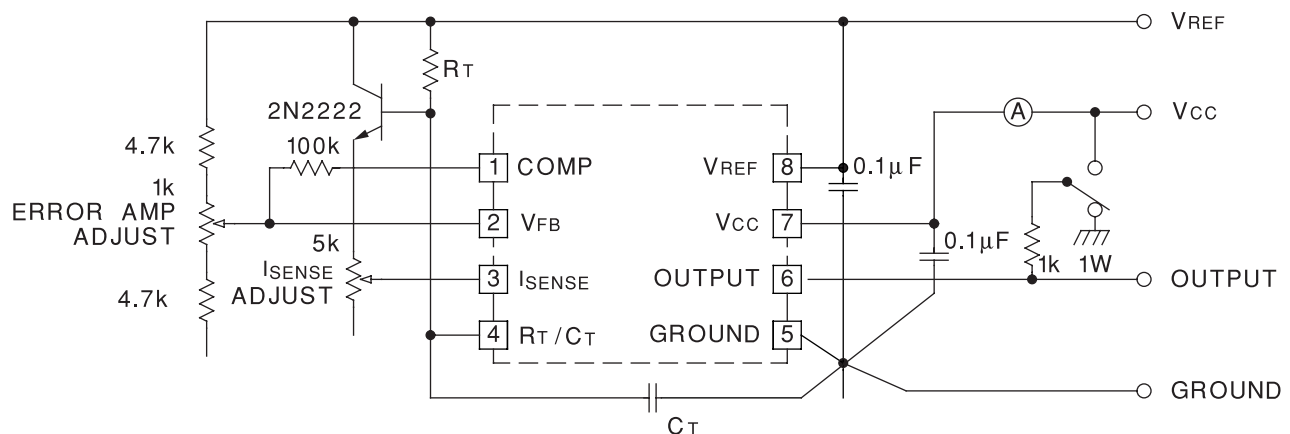
External compensation components for stability should also be placed close to the IC. TI recommends to also use surface mount components for the same reasons discussed for the filter capacitors. These should not be located very close to the inductor either.

11.1.4 Traces and Ground Planes

Make all of the power (high-current) traces as short, direct, and thick as possible. It is good practice on a standard PCB to make the traces an absolute minimum of 15 mils (0.381 mm) per ampere. The inductor, output capacitors, and output diode should be as close as possible to each other. This helps reduce the EMI radiated by the power traces due to the high-switching currents through them. This also reduces lead inductance and resistance, which in turn reduces noise spikes, ringing, and resistive losses that produce voltage errors. The grounds of the IC, input capacitors, output capacitors, and output diode (if applicable) should be connected close together directly to a ground plane. It would also be a good idea to have a ground plane on both sides of the PCB. This reduces noise by reducing ground loop errors and absorbing more of the EMI radiated by the inductor.

For multi-layer boards with more than two layers, a ground plane can be used to separate the power plane (where the power traces and components are) and the signal plane (where the feedback and compensation and components are) for improved performance. On multi-layer boards, vias are required to connect traces and different planes. It is a good practice to use one standard via per 200 mA of current if the trace needs to conduct a significant amount of current from one plane to the other. Arrange the components so that the switching current loops curl in the same direction. Due to the way switching regulators operate, there are two power states: one state when the switch is on and one when the switch is off. During each state there is a current loop made by the power components that are currently conducting. Place the power components so that during each of the two states the current loop is conducting in the same direction. This prevents magnetic field reversal caused by the traces between the two half-cycles and reduces radiated EMI.

11.2 Layout Example



High peak currents associated with capacitive loads necessitate careful grounding techniques. Timing and bypass capacitors should be connected close to pin 5 in a single point ground. The transistor and 5k potentiometer are used to sample the oscillator waveform and apply an adjustable ramp to pin 3.

Figure 24. Open-Loop Laboratory Test Fixture

12 器件和文档支持

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12.5 术语表

SLYZ022 — TI 术语表。

这份术语表列出并解释术语、缩写和定义。

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以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

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Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8670408VPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8670408VPA UC1845A	Samples
5962-8670408VXA	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 8670408VXA UC1845AL QMLV	Samples
5962P8670411VPA	ACTIVE	CDIP	JG	8	50	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	P8670411VPA UC1845A-SP	Samples
5962P8670411VYC	ACTIVE	CFP	HKU	10	25	RoHS-Exempt & Green	NIAU	N / A for Pkg Type	-55 to 125	P8670411VYC UC1845A-SP	Samples

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ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

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OBSOLETE: TI has discontinued the production of the device.

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(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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- Enhanced Product : [UC1845A-EP](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Enhanced Product - Supports Defense, Aerospace and Medical Applications

TUBE


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
5962-8670408VXA	FK	LCCC	20	55	506.98	12.06	2030	NA
5962P8670411VPA	JG	CDIP	8	50	506.98	15.24	13440	NA
5962P8670411VYC	HKU	CFP	10	25	506.98	26.16	6220	NA

PACKAGE OUTLINE

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package can be hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification.
5. Falls within MIL STD 1835 GDIP1-T8

EXAMPLE BOARD LAYOUT

JG0008A

CDIP - 5.08 mm max height

CERAMIC DUAL IN-LINE PACKAGE



LAND PATTERN EXAMPLE
NON SOLDER MASK DEFINED
SCALE: 9X

4230036/A 09/2023

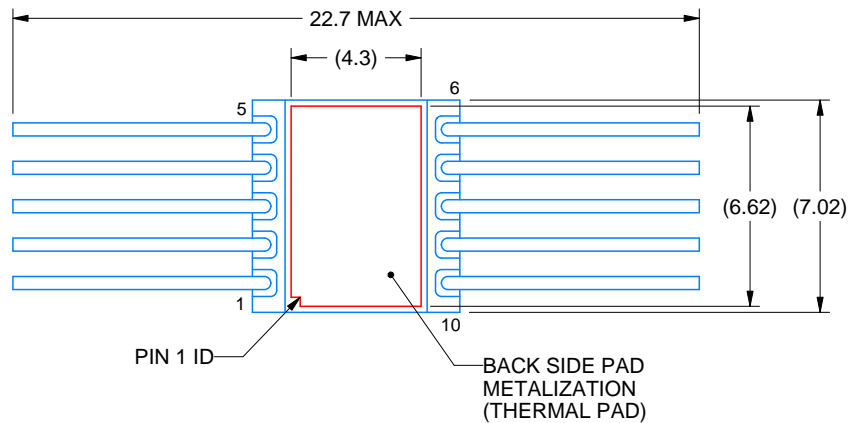
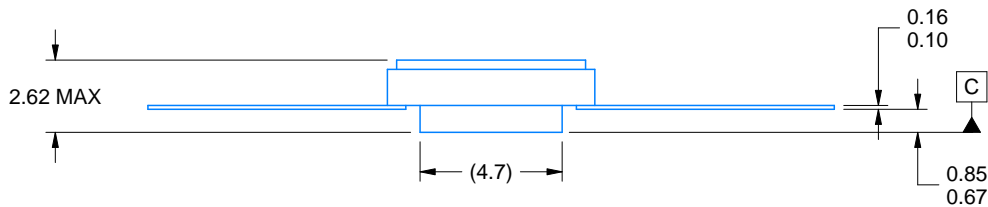
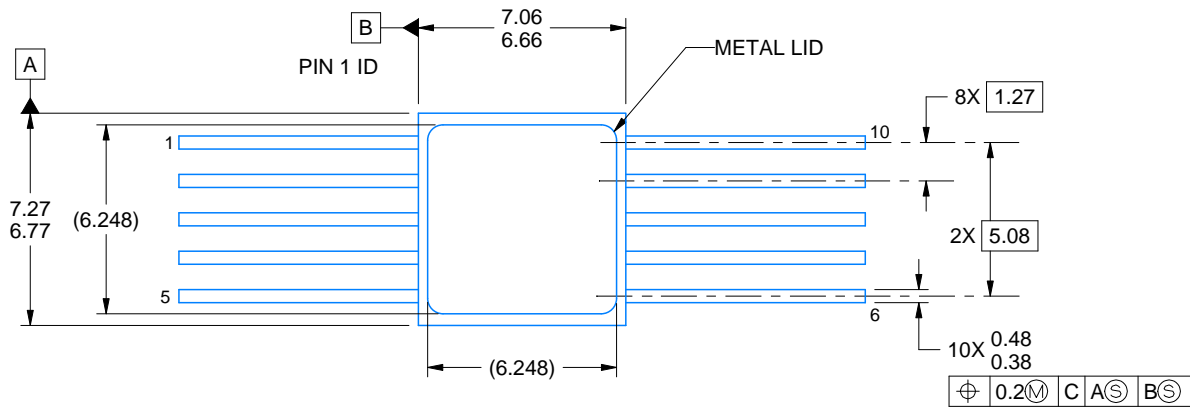


PACKAGE OUTLINE

HKU0010A

CFP - 2.63mm max height

CERAMIC DUAL FLATPACK



4226200/A 09/2020

NOTES:

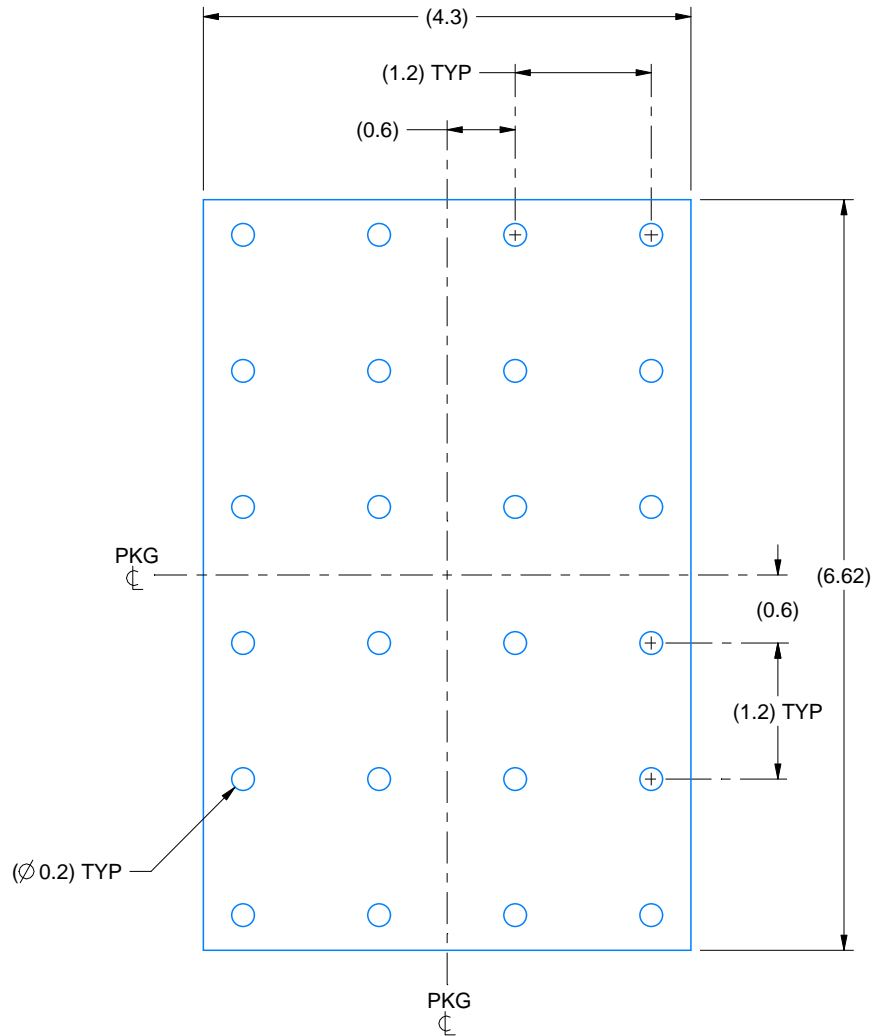
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a metal lid.
4. The terminals are gold plated.
5. This drawing does not comply with MIL STD 1835. Do not use this package for compliant product.
6. Metal lid is connected to back side pad metalization.

EXAMPLE BOARD LAYOUT

HKU0010A

CFP - 2.63mm max height

CERAMIC DUAL FLATPACK



HEATSINK LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X

GENERIC PACKAGE VIEW

FK 20

LCCC - 2.03 mm max height

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4229370VA\

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